

UNISONIC TECHNOLOGIES CO., LTD

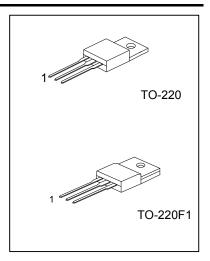
12N80 **Preliminary Power MOSFET**

12A, 800V **N-CHANNEL POWER MOSFET**

DESCRIPTION

The UTC 12N80 is an N-channel enhancement mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology is specialized in allowing a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

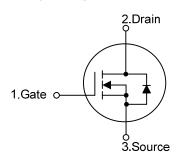
The UTC 12N80 is universally applied in high efficiency switch mode power supply.



FEATURES

- * $R_{DS(on)} = 0.9\Omega @V_{GS} = 10 \text{ V}$
- * High switching speed
- * Improved dv/dt capability
- * 100% avalanche tested

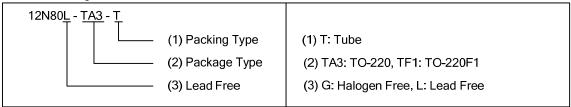
SYMBOL



ORDERING INFORMATION

Ordering Number		Doolsons	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
12N80L-TA3-T	12N80G-TA3-T	TO-220	G	D	S	Tube	
12N80L-TF1-T	12N80G-TF1-T	TO-220F1	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



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■ **ABSOLUTE MAXIMUM RATINGS** (T_C = 25°C unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	800	V
Gate-Source Voltage		V_{GSS}	±30	V
Drain Current	Continuous (T _C =25°C)	I_D	12	Α
	Pulsed (Note 2)	I _{DM}	48	Α
Avalanche Current (Note 2)		I _{AR}	12	Α
Dower Dissipation	TO-220	ב	225	W
Power Dissipation	TO-220F1	P_{D}	51	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55~+150	°C

Note: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient		θ_{JA}	62.5	°C/W
lunction to Coop	TO-220	0	0.56	°C/W
Junction to Case	TO-220F1	$\theta_{ m JC}$	2.43	°C/W

^{2.} Repetitive Rating: Pulse width limited by maximum junction temperature

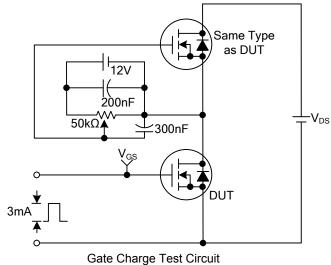
■ **ELECTRICAL CHARACTERISTICS** (T_C = 25°C unless otherwise specified)

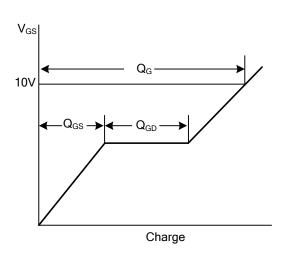
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS					•	•	
Drain-Source Breakdown Voltage		BV _{DSS}	I _D =250μA, V _{GS} =0V				V
Breakdown Voltage Temperature Coefficient		$\triangle BV_{DSS}/\triangle T_{J}$	I _D =250μA, Referenced to 25°C		1.0		V/°C
Drain-Source Leakage Current		Ince	V _{DS} =800V, V _{GS} =0V			10	
			V _{DS} =640V, T _C =125°C			100	μA
Gate- Source Leakage Current	Forward		V_{GS} =+30V, V_{DS} =0V			100	nA
	Reverse		V _{GS} =-30V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$			5.0	V
Static Drain-Source On-State Re	Static Drain-Source On-State Resistance		V _{GS} =10V, I _D =6A		0.75	0.9	Ω
DYNAMIC PARAMETERS							
Input Capacitance		C _{ISS}	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		4200		pF
Output Capacitance		Coss			315		pF
Reverse Transfer Capacitance		C _{RSS}			90		pF
SWITCHING PARAMETERS							
Total Gate Charge		Q_G	-V _{GS} =10V, V _{DS} =640V, I _D =12A -(Note 1, 2)		123	155	nC
Gate to Source Charge		Q_GS			27	45	nC
Gate to Drain Charge		Q_GD			49	80	nC
Turn-ON Delay Time		t _{D(ON)}			18	50	ns
Rise Time		t_R	V_{DD} =400V, I_{D} =12A, R_{G} =25 Ω		12	50	ns
Turn-OFF Delay Time		t _{D(OFF)}	(Note 1, 2)		51	100	ns
Fall-Time		t_{F}			18	50	ns
SOURCE- DRAIN DIODE RATIF	NGS AND CI	HARACTERIST	rics				
Maximum Body-Diode Continuous Current		Is				12	Α
Maximum Body-Diode Pulsed Current		I _{SM}				48	Α
Drain-Source Diode Forward Voltage		V_{SD}	I _S =12A, V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time		t _{rr}	V _{GS} =0V, I _S =12A, dI _F /dt=100A/μs		1000		ns
Body Diode Reverse Recovery Charge		Q _{RR}	(Note 1)		17.0		μC

Note: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

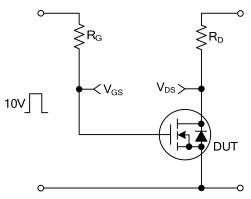
^{2.} Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

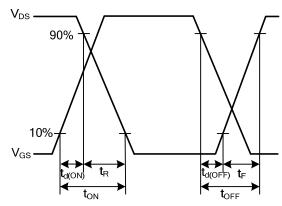




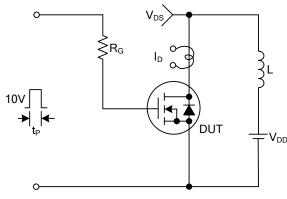
rge Test Circuit Gate Charge Waveforms



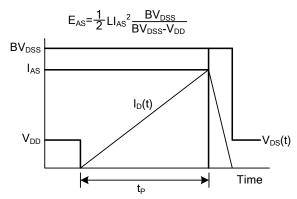
Resistive Switching Test Circuit



Resistive Switching Waveforms

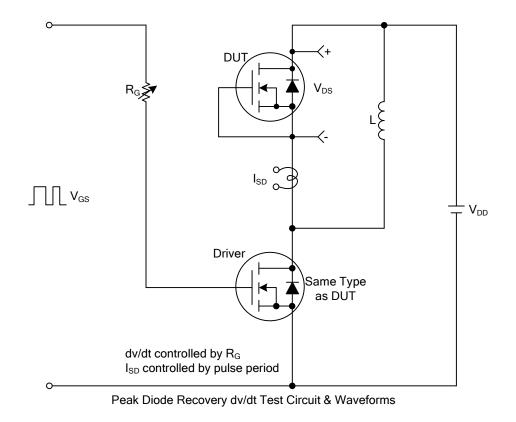


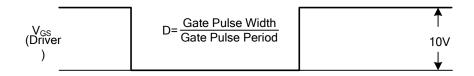
Unclamped Inductive Switching Test Circuit

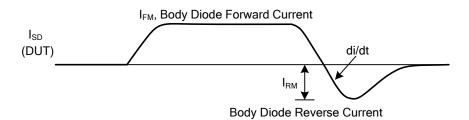


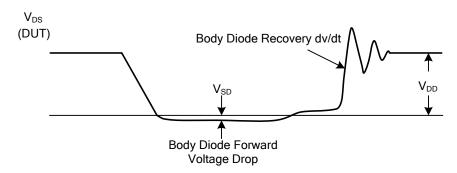
Unclamped Inductive Switching Waveforms

■ TEST CIRCUITS AND WAVEFORMS(Cont.)









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